

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10542278	TAN, BENG GHEE
	<b>Examiner</b>	<b>Art Unit</b>
	Roberto Velez	2829

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST Search:(US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT_IBM) PLUS Search and Text Search (See Search History)	5/8/2009	RV

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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